FAIRCHILD SEMICONDUCTOR TM

May 1996

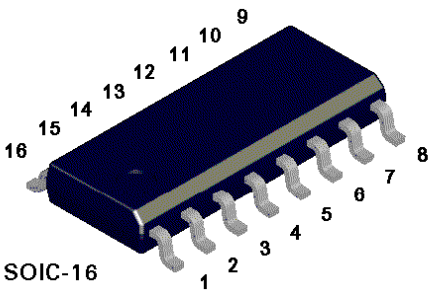
NDM3000
3 Phase Brushless Motor Driver

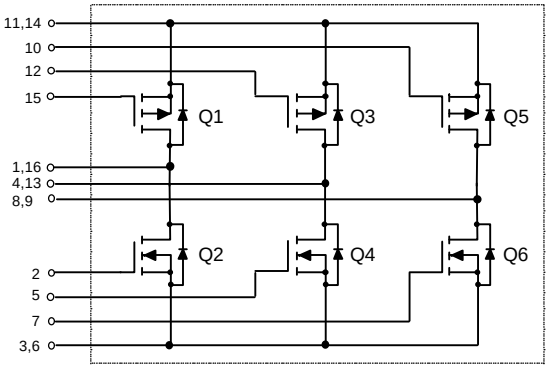
General Description

The NDM3000 three phase brushless motor driver consists of three N-Channel and P-Channel MOSFETs in a half bridge configuration. These devices are produced using Fairchild's proprietary, high cell density DMOS technology. This very high density process is tailored to minimize on-state resistance which reduces power loss, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage 3 phase motor driver such as disk drive spindle motor control and other half bridge applications.

Features

- ±3.0A, ±30V, 2.5W
- High density cell design for extremely low $R_{DS(ON)}$.
- High power and current handling capability.
- Industry standard SOIC-16 surface mount package.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	NDM3000	Units
V_{DSS}	Drain-Source Voltage (All Types)	± 30	V
V_{GSS}	Gate-Source Voltage (All Types)	± 20	V
I_D	Drain Current Q1+Q4 or Q1+Q6 or Q3+Q2 - Continuous Q3+Q6 or Q5+Q2 or Q5+Q4	± 3.0	A
	- Pulsed (Note 1a & 2)	± 10	
P_D	Total Power Dissipation (Note 1a)	2.5	W
	Q1+Q4 or Q1+Q6 or Q3+Q2 or Q3+Q6 or Q5+Q2 or Q5+Q4 (Note 1b)	1.6	
	(Note 1c)	1.4	
T_J,T_{STG}	Operating and Storage Temperature Range	-55 to 150	°C

THERMAL CHARACTERISTICS			
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient Q1+Q4 or Q1+Q6 or Q3+Q2 or Q3+Q6 or Q5+Q2 or Q5+Q4 (Note 1a)	50	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case Q1+Q4 or Q1+Q6 or Q3+Q2 or Q3+Q6 or Q5+Q2 or Q5+Q4 (Note 1)	20	°C/W

Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Conditions	Type	Min	Typ	Max	Units
OFF CHARACTERISTICS							
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = ± 250 µA	All	±30			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = ±20 V, V_{GS} = 0 V	All			±1	µA
		T_J=55°C				±25	µA
I_{GSS}	Gate - Body Leakage, Forward	V_{GS} = ±20 V, V_{DS} = 0 V	All			±100	nA
ON CHARACTERISTICS (Note 3)							
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = -250 µA	Q1, Q3, Q5	-1	-1.6	-3	V
		T_J=125°C		-0.7	-1.25	-2.2	
		V_{DS} = V_{GS}, I_D = 250 µA	Q2, Q4, Q6	1	1.7	3	
		T_J=125°C		0.7	1.2	2.2	
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS} = -10 V, I_D = -3.0 A	Q1, Q3, Q5		0.125	0.16	Ω
		T_J=125°C			0.18	0.29	
		V_{GS} = -4.5 V, I_D = -1.0 A			0.16	0.25	
		V_{GS} = 10 V, I_D = 3.0 A	Q2, Q4, Q6		0.07	0.09	
		T_J=125°C			0.1	0.16	
		V_{GS} = 4.5 V, I_D = 1.0 A			0.09	0.13	
$I_{D(on)}$	On-State Drain Current	V_{GS} = -10 V, V_{DS} = -5 V	Q1, Q3, Q5	-10			A
		V_{GS} = 10 V, V_{DS} = 5 V	Q2, Q4, Q6	10			
DYNAMIC CHARACTERISTICS							
C_{iss}	Input Capacitance	Q1, Q3, Q5 V_{DS} = -10 V, V_{GS} = 0 V, f = 1.0 MHz	Q1, Q3, Q5		375		pF
			Q2, Q4, Q6		360		
C_{oss}	Output Capacitance	Q2, Q4, Q6 V_{DS} = 10 V, V_{GS} = 0 V, f = 1.0 MHz	Q1, Q3, Q5		245		pF
			Q2, Q4, Q6		260		
C_{rss}	Reverse Transfer Capacitance		Q1, Q3, Q5		130		pF
			Q2, Q4, Q6		105		

Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Conditions	Type	Min	Typ	Max	Units
SWITCHING CHARACTERISTICS (Note 3)							
$t_{D(on)}$	Turn - On Delay Time	Q1, Q3, Q5 V_{DD} = -15 V, I_D = -1 A, V_{GEN} = -10 V, R_{GEN} = 6 Ω	Q1, Q3, Q5		10	40	ns
			Q2, Q4, Q6		9	40	
t_r	Turn - On Rise Time		Q1, Q3, Q5		13	40	ns
			Q2, Q4, Q6		21	40	
$t_{D(off)}$	Turn - Off Delay Time	Q2, Q4, Q6 V_{DD} = 15 V, I_D = 1 A, V_{GEN} = 10 V, R_{GEN} = 6 Ω	Q1, Q3, Q5		21	90	ns
			Q2, Q4, Q6		21	90	
t_f	Turn - Off Fall Time		Q1, Q3, Q5		5	50	ns
			Q2, Q4, Q6		8	50	
Q_g	Total Gate Charge	Q1, Q3, Q5 V_{DS} = -10 V, I_D = -3.0 A, V_{GS} = -10 V	Q1, Q3, Q5		10	25	nC
			Q2, Q4, Q6		9.5	25	
Q_{gs}	Gate-Source Charge		Q1, Q3, Q5		1.6		nC
		Q2, Q4, Q6 V_{DS} = 10 V, I_D = 3.0 A, V_{GS} = 10 V	Q2, Q4, Q6		1.5		
Q_{gd}	Gate-Drain Charge		Q1, Q3, Q5		3		nC
			Q2, Q4, Q6		2.5		
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS							
I_S	Maximum Continuous Drain-Source Diode Forward Current		Q1, Q3, Q5			-1.2	A
			Q2, Q4, Q6			1.2	
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = -3.0 A (Note 3)	Q1, Q3, Q5		-0.8	-1.3	V
		V_{GS} = 0 V, I_S = 3.0 A (Note 3)	Q2, Q4, Q6		0.8	1.3	
t_{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_F = ±3.0 A, dI_F/dt = 100 A/µs	All			100	ns

Notes:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

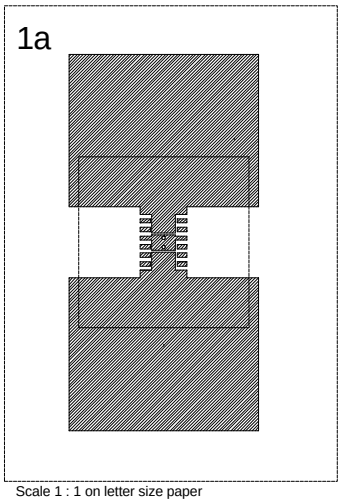
$$P_D(t) = \frac{T_J - T_A}{R_{\theta JA}(t)} = \frac{T_J - T_A}{R_{\theta JC} + R_{\theta CA}(t)} = I_D^2(t) \times R_{DS(ON)@T_J}$$

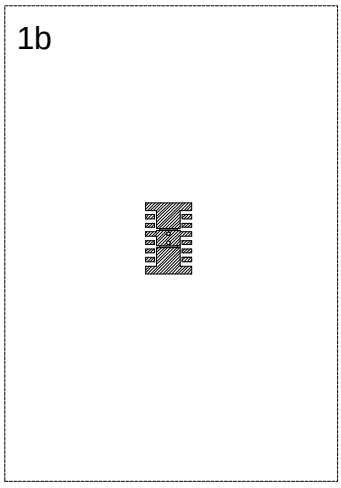
Typical $R_{\theta JA}$ using the board layouts shown below on 4.5"x5" FR-4 PCB in a still air environment:

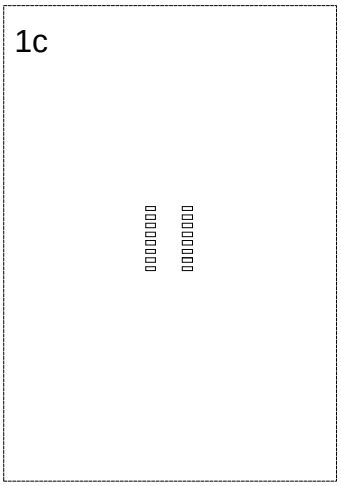
a. 50°C/W when mounted on a 1 in^2 pad of 2oz cpper.

b. 80°C/W when mounted on a 0.027 in^2 pad of 2oz cpper.

c. 90°C/W when mounted on a 0.0028 in^2 pad of 2oz cpper.







Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2.0%.

Typical Electrical Characteristics

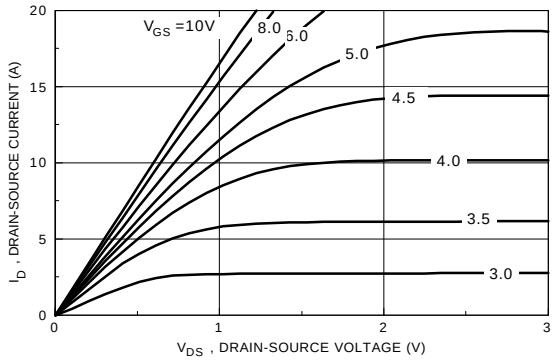


Figure 1. N-Channel On-Region Characteristic.

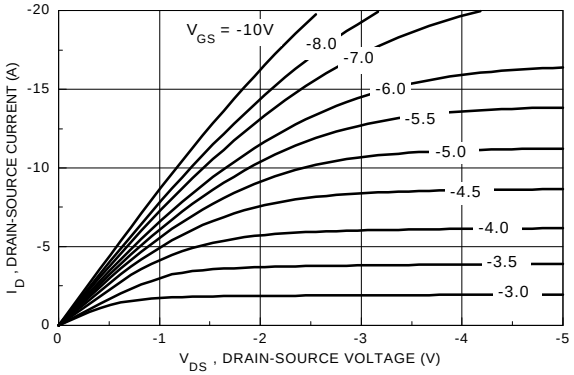


Figure 2. P-Channel On-Region Characteristics.

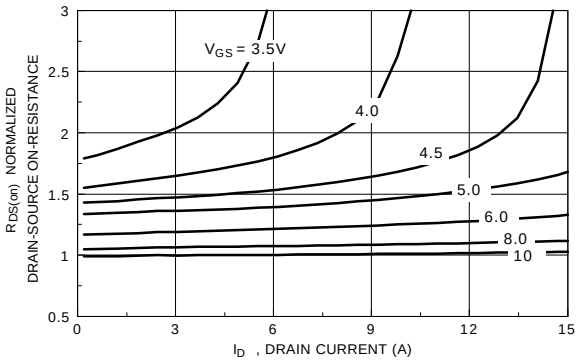


Figure 3. N-Channel On-Resistance Variation with Gate Voltage and Drain Current.

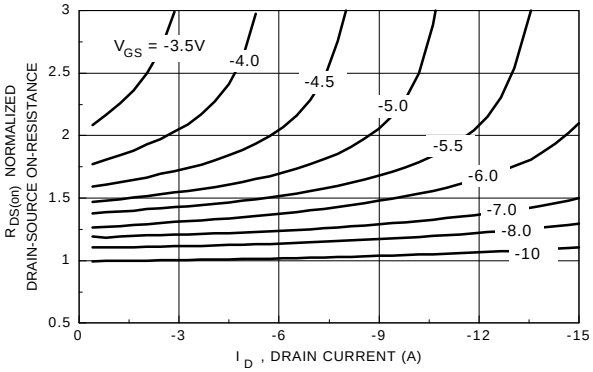


Figure 4. P-Channel On-Resistance Variation with Gate Voltage and Drain Current.

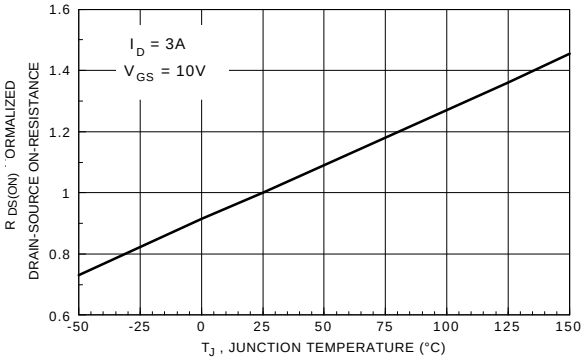


Figure 5. N-Channel On-Resistance Variation with Temperature.

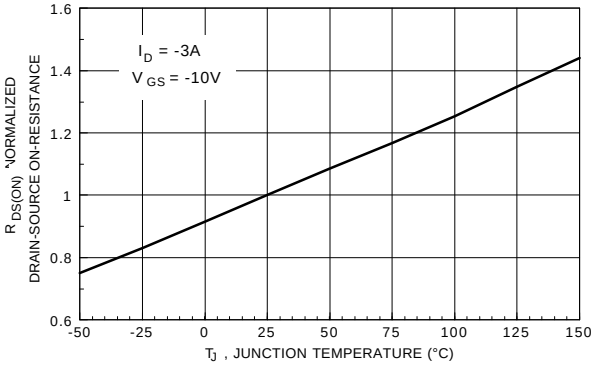


Figure 6. P-Channel On-Resistance Variation with Temperature.

Typical Electrical Characteristics

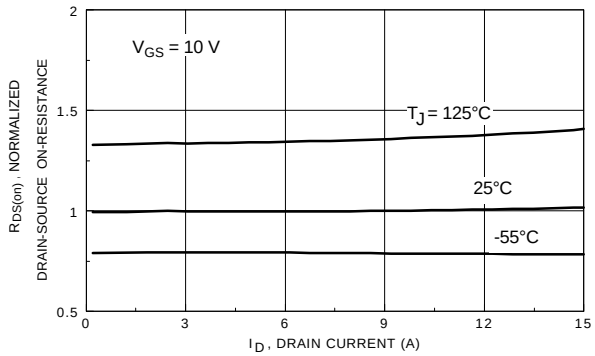


Figure 7. N-Channel On-Resistance Variation with Drain Current and Temperature.

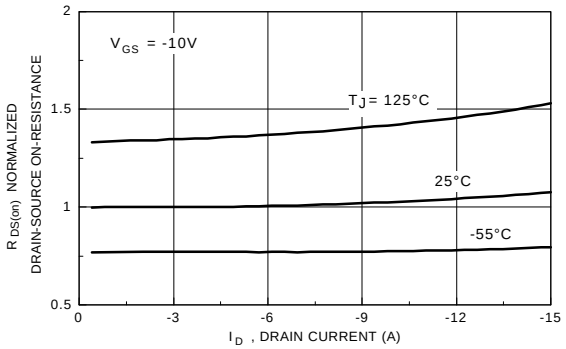


Figure 8. P-Channel On-Resistance Variation with Drain Current and Temperature.

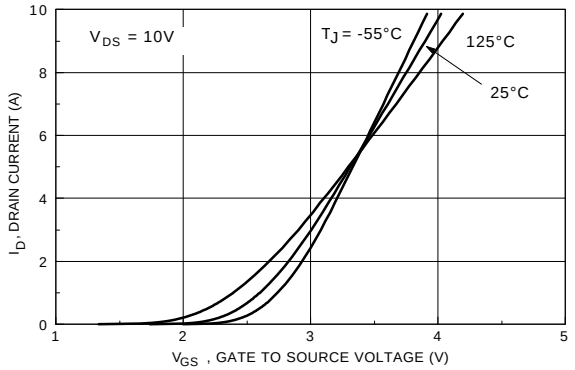


Figure 9. N-Channel Transfer Characteristics.

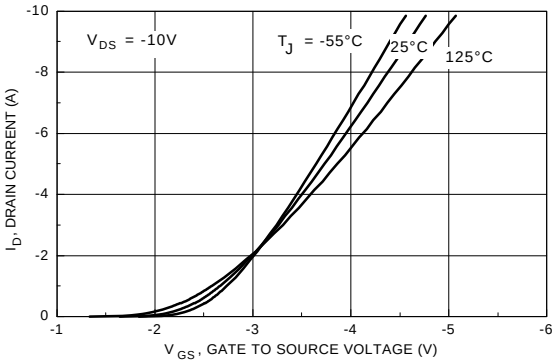


Figure 10. P-Channel Transfer Characteristics.

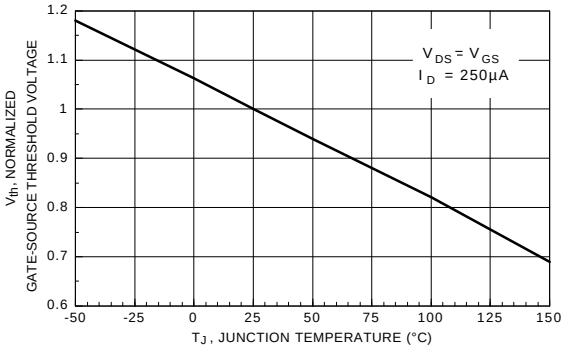


Figure 11. N-Channel Gate Threshold Variation with Temperature.

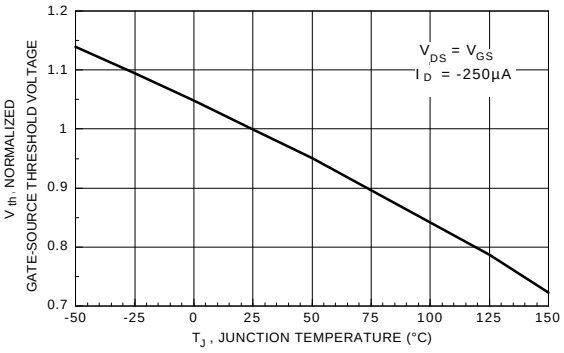


Figure 12. P-Channel Gate Threshold Variation with Temperature.

Typical Electrical Characteristics

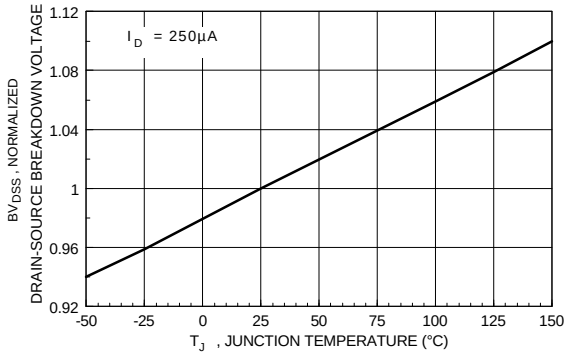


Figure 13. N-Channel Breakdown Voltage Variation with Temperature.

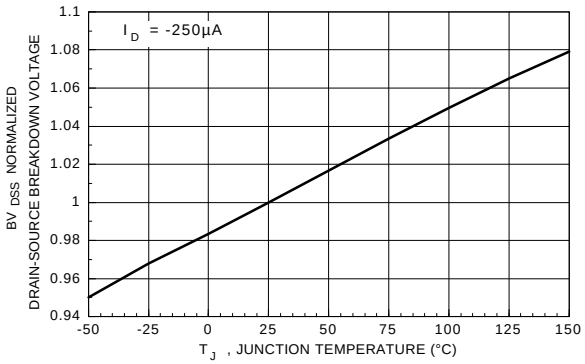


Figure 14. P-Channel Breakdown Voltage Variation with Temperature.

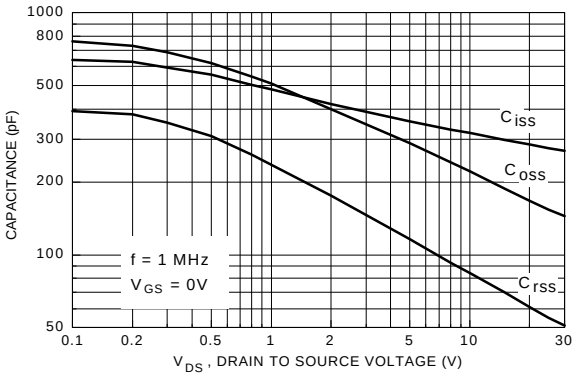


Figure 15. N-Channel Capacitance Characteristics.

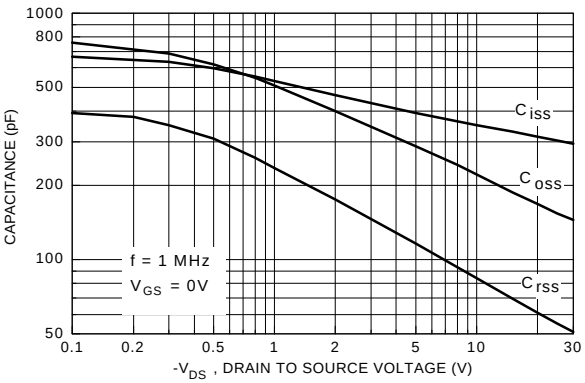


Figure 16. P-Channel Capacitance Characteristics.

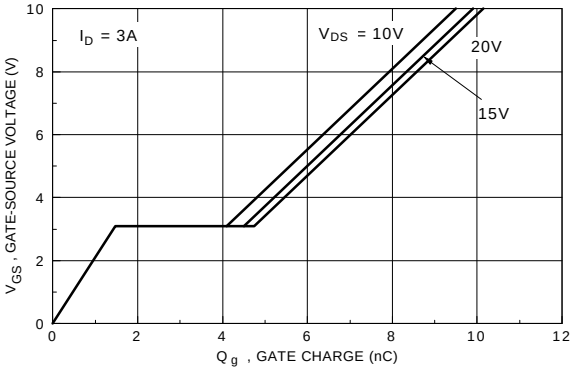


Figure 17. N-Channel Gate Charge Characteristics.

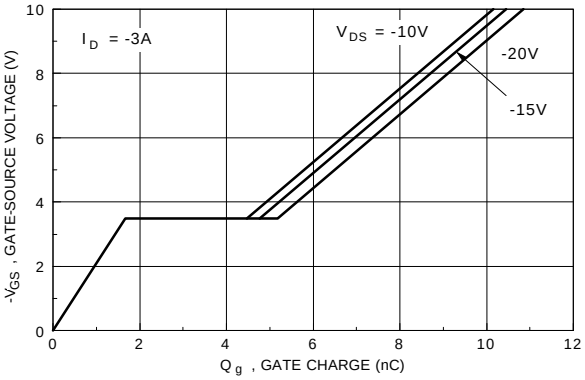


Figure 18. P-Channel Gate Charge Characteristics.

Typical Electrical Characteristics

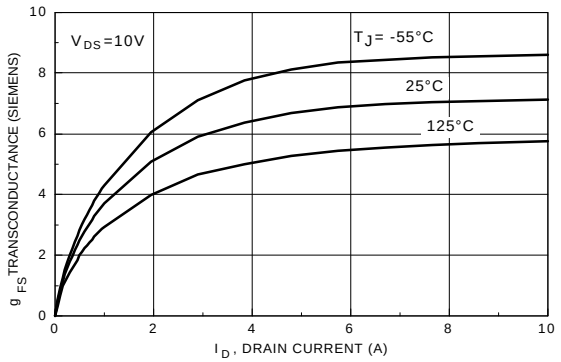


Figure 19. N-Channel Transconductance Variation with Drain Current and Temperature.

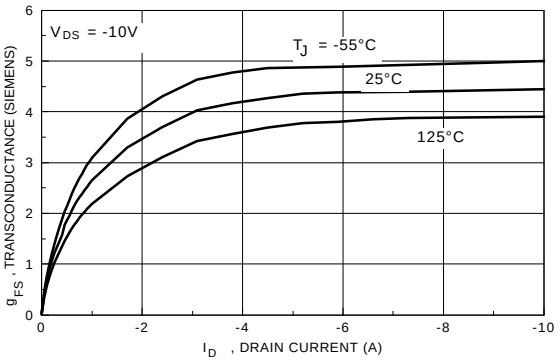


Figure 20. P-Channel Transconductance Variation with Drain Current and Temperature.

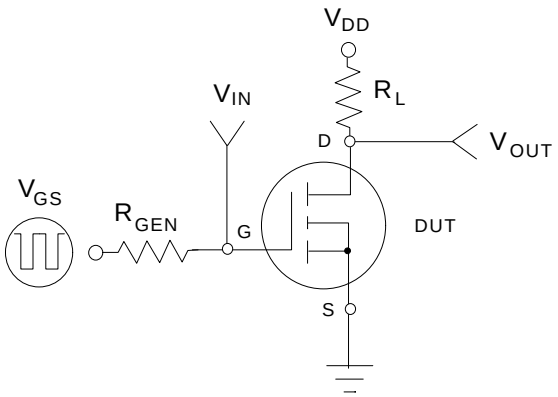


Figure 21. N or P-Channel Switching Test Circuit.

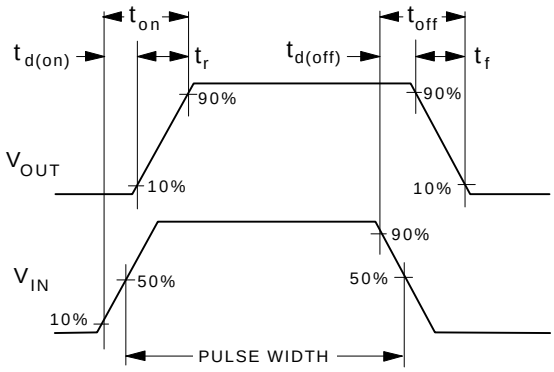


Figure 22. N or P-Channel Switching Waveforms.

Typical Thermal and Electrical Characteristics

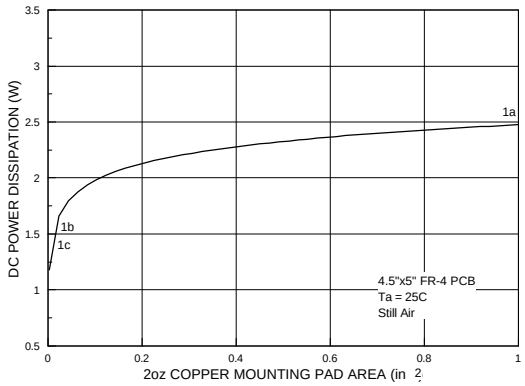


Figure 23. SOIC-16 3 Leadframe Device DC Power Dissipation versus Copper Mounting Pad Area

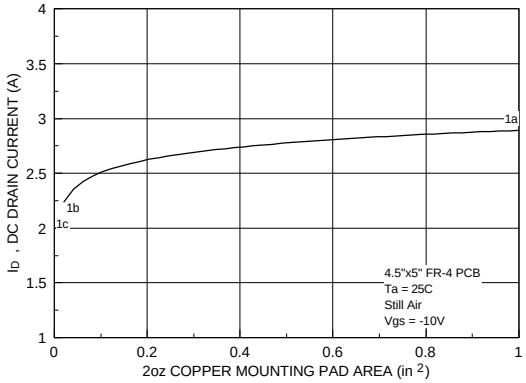


Figure 24. P-Ch DC Drain Current Capability versus Copper Mounting Pad Area.

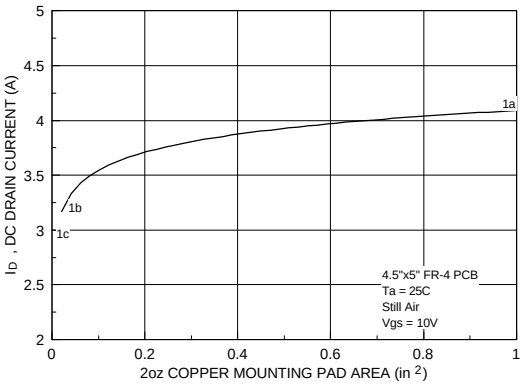


Figure 25. N-Ch DC Drain Current Capability versus Copper Mounting Pad Area.

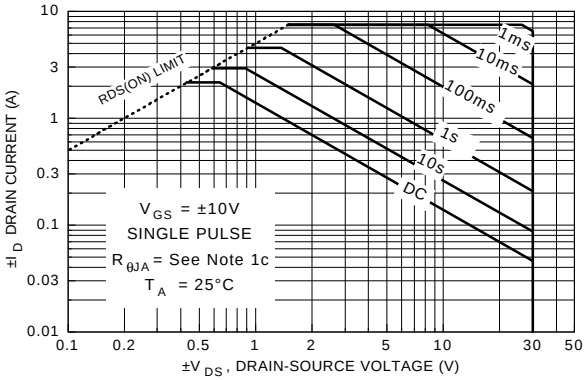


Figure 26. P-Ch Typical Safe Operating Area

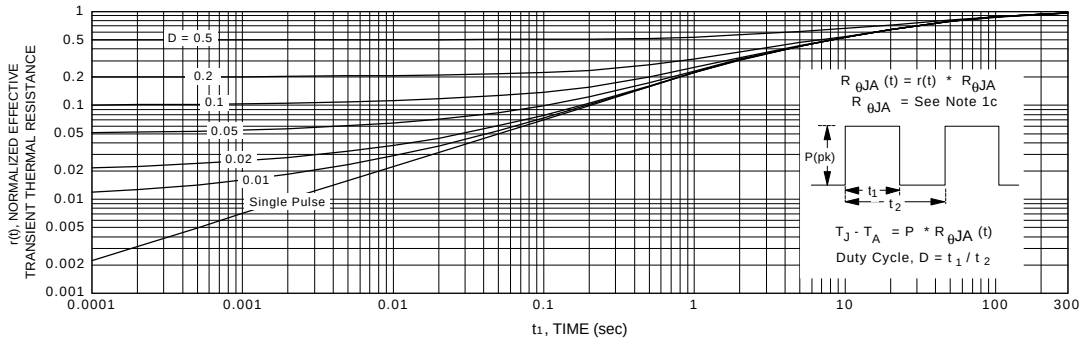


Figure 27. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in note 1c. Transient thermal response will change depending on the circuit board design.

SOIC-16 Tape and Reel Data and Package Dimensions

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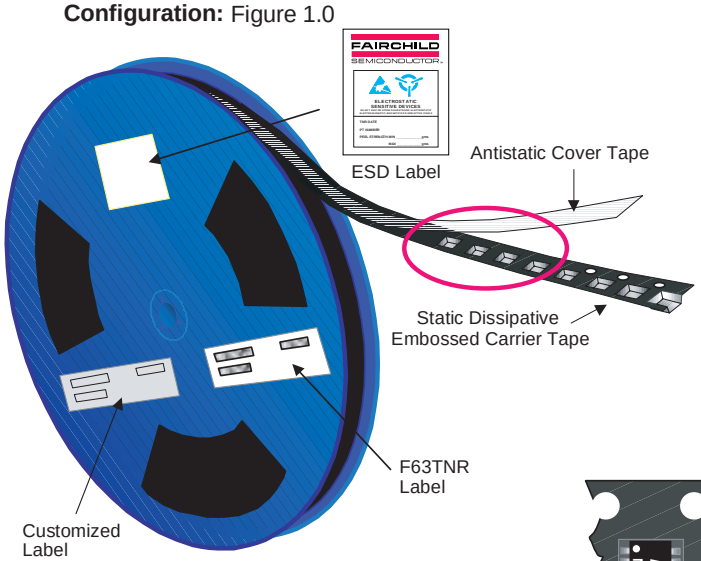
SOIC(16lds) Packaging Configuration: Figure 1.0

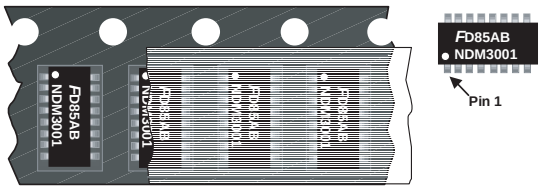


Packaging Description:

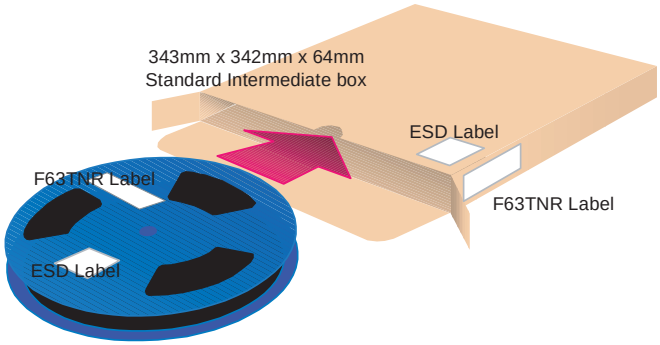
SOIC-16 parts are shipped in tape. The carrier tape is made from a dissipative (carbon filled) polycarbonate resin. The cover tape is a multilayer film (Heat Activated Adhesive in nature) primarily composed of polyester film, adhesive layer, sealant, and anti-static sprayed agent. These reeled parts in standard option are shipped with 2,500 units per 13" or 330cm diameter reel. The reels are dark blue in color and is made of polystyrene plastic (anti-static coated). This and some other options are further described in the Packaging Information table.

These full reels are individually barcode labeled and placed inside a standard intermediate box (illustrated in figure 1.0) made of recyclable corrugated brown paper. One box contains two reels maximum. And these boxes are placed inside a barcode labeled shipping box which comes in different sizes depending on the number of parts shipped.

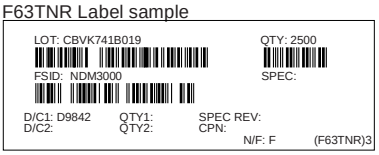
SOIC (16lds) Packaging Information		
Packaging Option	Standard (no flow code)	L86Z
Packaging type	TNR	Rail/Tube
Qty per Reel/Tube/Bag	2,500	45
Reel Size	13" Dia	-
Box Dimension (mm)	343x64x343	530x130x83
Max qty per Box	5,000	13,500
Weight per unit (gm)	0.1437	0.1437
Weight per Reel (kg)	0.7735	-
Note/Comments		



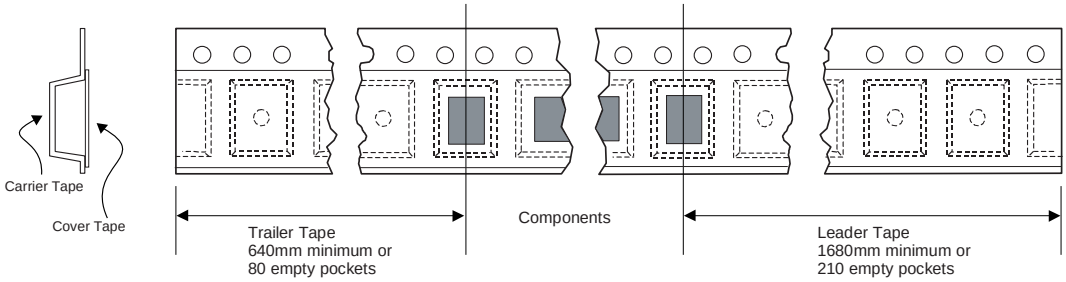
SOIC-16 Unit Orientation



F63TNR Label sample



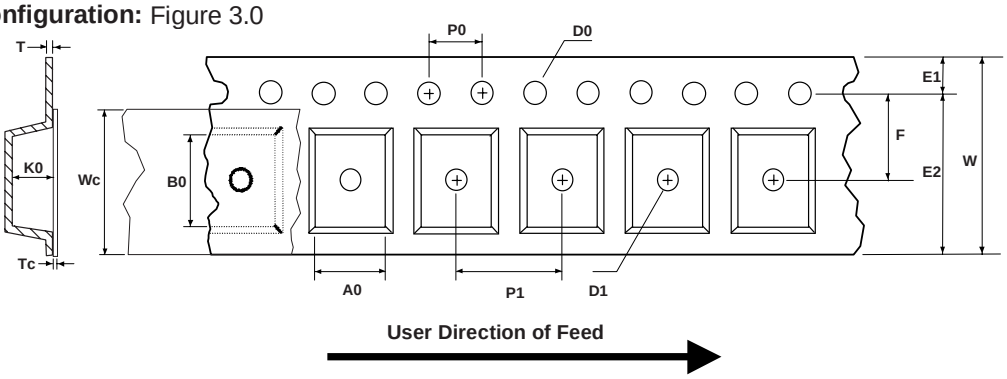
SOIC(16lds) Tape Leader and Trailer Configuration: Figure 2.0



October 1999, Rev. B

SOIC-16 Tape and Reel Data and Package Dimensions, continued

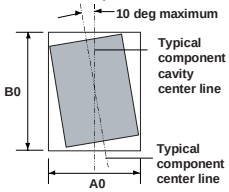
SOIC(16lds) Embossed Carrier Tape
Configuration: Figure 3.0



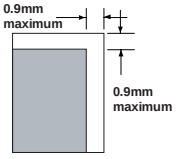
Dimensions are in millimeter														
Pkg type	**A0**	**B0**	**W**	**D0**	**D1**	**E1**	**E2**	**F**	**P1**	**P0**	**K0**	**T**	**Wc**	**Tc**
SOIC(16lds) (16mm)	6.60 +/-0.30	10.35 +/-0.25	16.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	14.25 min	7.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	2.40 +/-0.40	0.450 +/-0.150	13.0 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).

Sketch A (Side or Front Sectional View)
Component Rotation

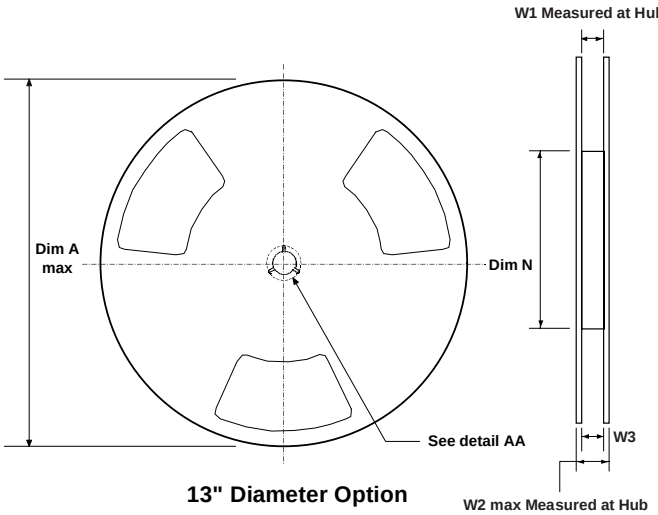


Sketch B (Top View)
Component Rotation



Sketch C (Top View)
Component lateral movement

SOIC(16lds) Reel Configuration: Figure 4.0

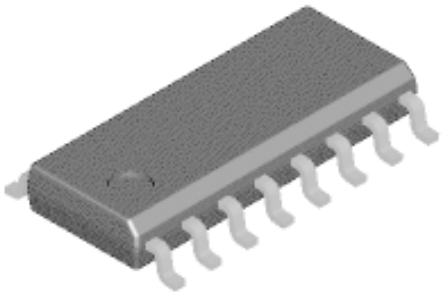


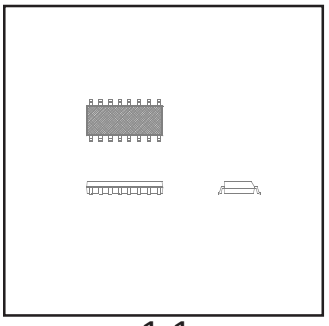
13" Diameter Option

Dimensions are in inches and millimeters									
Tape Size	**Reel Option**	**Dim A**	**Dim B**	**Dim C**	**Dim D**	**Dim N**	**Dim W1**	**Dim W2**	**Dim W3 (LSL-USL)**
16mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	4.00 100	0.646 +0.078/-0.000 16.4 +2/0	0.882 22.4	0.626 – 0.764 15.9 – 19.4

SOIC-16 Tape and Reel Data and Package Dimensions, continued

SOIC-16 (FS PKG Code S3)



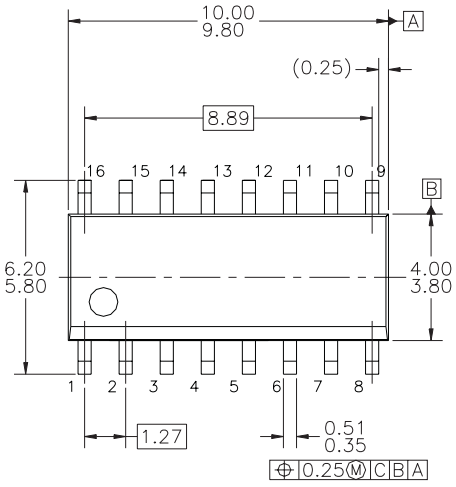


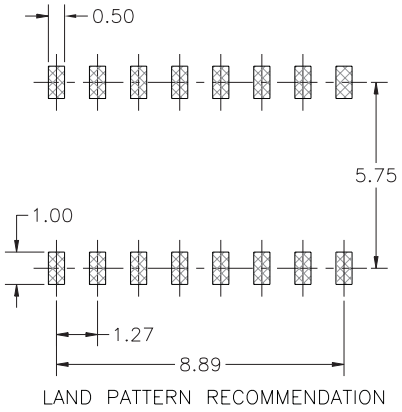
1:1

Scale 1:1 on letter size paper

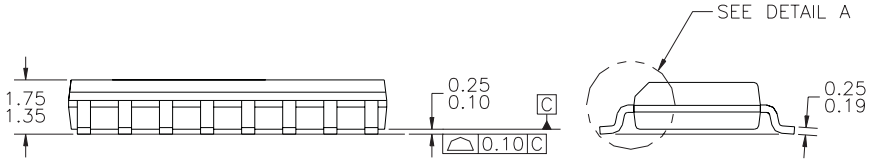
Dimensions shown below are in:
inches [millimeters]

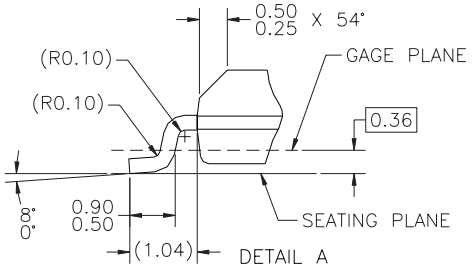
Part Weight per unit (gram): 0.1437





LAND PATTERN RECOMMENDATION





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